SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017

GEFEN ELECTRONIC SERVICES LTD
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CALIBRATION

Valid To: June 30, 2027 Certificate Number: 3537.01

In recognition of the successful completion of the A2LA evaluation process (including an assessment of the organization's compliance with R205 – A2LA's Calibration Program Requirements), accreditation is granted to this laboratory to perform the following calibrations[1, 7]:

I. Acoustics

Parameter/Equipment	Range	CMC[2, 6] (±)	Comments
Sound – Measuring Equipment	94 dB 114 dB	0.26 dB 0.26 dB	Sound calibrator Bruel & Kjaer Type 4231

II. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC[2, 5] (±)	Comments
DC Voltage – Generate[3]	2.2 µV to 220 mV 220 mV to 2.2 V (2.2 to 11) V (11 to 22) V (22 to 220) V (220 to 1100) V	12 µV/V + 0.9 µV 8.7 µV/V + 1.5 µV 8.6 µV/V + 5.2 µV 8.6 µV/V + 8.2 µV 11 µV/V + 110 µV 12 µV/V + 580 µV	Fluke 5700A

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Parameter/Equipment	Range	CMC[2, 4, 5] (±)	Comments
DC Voltage – Measure[3]	Up to 100 mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 1000) V	14 µV/V + 0.3 µV 11 µV/V + 0.3 µV 11 µV/V + 0.5 µV 13 µV/V + 30 µV 15 µV/V + 0.1 mV	Agilent 3458A
DC High Voltage – Measure[3]	Up to 500 V (500 to 1000) V (1000 to 1500) V (1500 to 3000) V (3000 to 6000) V	0.28 V 0.44 V 1.7 V 14 V 14 V	Vitrek 4700
DC Current – Generate[3]	(0.02 to 220) µA 220 µA to 2.2 mA (2.2 to 22) mA (22 to 220) mA 220 mA to 2.2 A (2 to 10) A	0.17 % + 9.3 nA 75 µA/A + 9.3 nA 75 µA/A + 93 nA 85 µA/A + 0.92 µA 0.014 % + 29 µA 0.024 % + 500 µA	Fluke 5700A
Clamp Meters	(10 to 16.999) A	0.6 % + 20 mA	Datron 4800 w/ Datron 4600 transconductance amplifier
	(17.0 to 149.99) A	0.6 % + 0.14 A	Fluke 5700A with 50 turn coil
	(150 to 1000) A	0.6 % + 0.5 A	Fluke 9100, Y5020 shunt & 50 turn coil
DC Current – Measure[3]	(10 to 100) µA 100 µA to 1 mA (1 to 10) mA (10 to 100) mA 100 mA to 1 A	34 µA/A + 8 nA 34 µA/A + 5 nA 34 µA/A + 0.1 µA 48 µA/A + 5 µA 0.13 % + 10 µA	Agilent 3458A
	(10 to 600) A (600 to 900) A	1.5 % + 1.5 A 2 % + 8 A	Clamp meter CM-6146

Parameter/Equipment	Range	CMC[2, 4, 5] (±)	Comments
Resistance – Generate, Fixed Points[3]	0 Ω (1, 1.9) Ω 10 Ω 19 Ω (100, 190) Ω 1 kΩ 1.9 kΩ (10, 19) kΩ (100, 190) kΩ 1 MΩ 1.9 MΩ 10 MΩ 19 MΩ 100 MΩ	58 μΩ 0.011 % 34 μΩ/Ω 33 μΩ/Ω 20 μΩ/Ω 16 μΩ/Ω 17 μΩ/Ω 17 μΩ/Ω 19 μΩ/Ω 26 μΩ/Ω 27 μΩ/Ω 61 μΩ/Ω 81 μΩ/Ω 0.021 %	Fluke 5700A
Resistance – Generate, Ranged Values[3]	(100.0 to 999.9) MΩ (1.000 to 9.9999) GΩ (10.000 to 19.999) GΩ	0.6 % 1.2 % 3.3 %	Fluke 5322A
Resistance – Measure[3]	(0 to 10) Ω (10 to 100) Ω 100 Ω to 1 kΩ (1 to 10) kΩ (10 to 100) kΩ 100 kΩ to 1 MΩ (1 to 10) MΩ (10 to 100) MΩ	33 μΩ/Ω + 50 μΩ 18 μΩ/Ω + 0.5 mΩ 17 μΩ/Ω + 0.5 mΩ 17 μΩ/Ω + 5 mΩ 19 μΩ/Ω + 0.05 Ω 36 μΩ/Ω + 0.002 kΩ 83 μΩ/Ω + 0.1 kΩ 0.063 % + 1 kΩ	Agilent 3458A

Parameter/Range	Frequency	CMC[2, 5] (±)	Comments
AC Voltage – Generate[3]			
(2.2 to 22) mV	(20 to 40) Hz 40 Hz to 20 kHz (20 to 100) kHz (100 to 300) kHz	0.078 % + 6 μV 0.066 % + 6 μV 0.14 % + 8.1 μV 0.29 % + 14 μV	Fluke 5700A
(22 to 220) mV	(20 to 40) Hz 40 Hz to 20 kHz (20 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.029 % + 9 μV 0.019 % + 9 μV 0.11 % + 29 μV 0.16 % + 29 μV 0.46 % + 93 μV	

Parameter/Range	Frequency	CMC[2, 5] (±)	Comments
AC Voltage – Generate[3] (cont)			
220 mV to 2.2 V	(20 to 40) Hz 40 Hz to 20 kHz (20 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.029 % + 9 µV 0.019 % + 10 µV 0.11 % + 29 µV 0.16 % + 29 µV 0.46 % + 92 µV	Fluke 5700A
(2.2 to 22) V	(20 to 40) Hz 40 Hz to 20 kHz (20 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.02 % + 290 µV 0.014 % + 70 µV 0.041 % + 0.4 mV 0.067 % + 1.7 mV 0.3 % + 10 mV	
(22 to 220) V	(20 to 40) Hz 40 Hz to 20 kHz (20 to 100) kHz	0.02 % + 2.9 mV 0.013 % + 0.9 mV 0.1 % + 9.2 mV	
(220 to 1100) V	(15 to 50) Hz 50 Hz to 1 kHz	0.05 % + 19 mV 0.014 % + 4 mV	
AC Voltage – Measure[3]			
Up to 10 mV	(40 to 100) Hz (0.1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 250) kHz	0.15 % + 0.025 mV 0.45 % + 0.025 mV 0.32 % + 0.025 mV 0.85 % + 0.035 mV 6 % + 0.07 mV	Agilent 3458A
(10 to 100) mV	(20 to 40) Hz (40 to 100) Hz (0.1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 250) kHz (250 to 500) kHz (500 to 1000) kHz	0.17 % + 0.02 mV 0.083 % + 0.01 mV 0.051 % + 0.01 mV 0.2 % + 0.04 mV 0.70 % + 0.08 mV 4.2 % + 0.5 mV 5 % + 0.6 mV 6.8 % + 2 mV	
100 mV to 1 V	(20 to 40) Hz (40 to 100) Hz (0.1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 250) kHz (250 to 500) kHz 500 kHz to 1 MHz	0.17 % + 0.2 mV 0.07 % + 0.1 mV 0.025 % + 0.1 mV 0.17 % + 0.4 mV 0.69 % + 0.8 mV 2.3 % + 10 mV 3.5 % + 10 mV 5.8 % + 20 mV	

Parameter/Range	Frequency	CMC[2, 5] (±)	Comments
AC Voltage – Measure[3] (cont)			
(1 to 10) V	(20 to 40) Hz (40 to 100) Hz (0.1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 250) kHz	0.18 % + 2 mV 0.07 % + 1 mV 0.024 % + 1 mV 0.17 % + 4 mV 0.69 % + 8 mV 2.3 % + 50 mV	Agilent 3458A
(10 to 100) V	(20 to 40) Hz (40 to 100) Hz (0.1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.17 % + 20 mV 0.07 % + 10 mV 0.035 % + 10 mV 0.17 % + 40 mV 0.69 % + 80 mV	
(100 to 700) V	(20 to 40) Hz (40 to 100) Hz (0.1 to 20) kHz (20 to 50) kHz	0.21 % + 0.3 V 0.11 % + 0.2 V 0.064 % + 0.2 V 0.18 % + 0.4 V	
AC High Voltage – Measure			
Up to 500 V (500 to 1000) V (1000 to 1500) V (1500 to 3000) V (3000 to 5000) V	50/60 Hz	0.87 V 1.6 V 10 V 34 V 36 V	Vitrek 4700
AC Current – Generate[3]			
(0.1 to 220) µA	40 Hz to 1 kHz (1 to 10) kHz	0.039 % + 19 nA 0.19 % + 92 nA	Fluke 5700A
220 µA to 2.2 mA	40 Hz to 1 kHz (1 to 10) kHz	0.029 % + 40 nA 0.19 % + 1.0 µA	
(2.2 to 22) mA	40 Hz to 1 kHz (1 to 10) kHz	0.029 % + 0.4 µA 0.19 % + 9.3 µA	
(22 to 220) mA	40 Hz to 1 kHz (1 to 10) kHz	0.029 % + 4.0 µA 0.19 % + 9.2 µA	
220 mA to 2.2 A	40 Hz to 1 kHz (1 to 10) kHz	0.089 % + 92 µA 1.0 % + 190 µA	

Parameter/Range	Frequency	CMC[2, 5] (±)	Comments
AC Current – Generate[3] (cont)			
(2 to 10) A	10 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 20) kHz	0.045 % + 1.4 mA 0.1 % + 1.8 mA 0.25 % + 6.9 mA 0.86 % + 39 mA	Datron 4800 w/ Datron 4600 transconductance amplifier
Clamp Meters:			
(10 to 16.999) A	50/60 Hz	0.6 % + 0.03 A	Fluke 5700A with 50 turn coil
(17.0 to 149.99) A		0.6 % + 0.25 A	
(150 to 1000) A		0.6 % +0.9 A	Fluke 9100, Y5020 shunt & 50 turn coil
AC Current – Measure[3]			
(5 to 100) µA 100 µA to 1 mA (1 to 10) mA (10 to 100) mA 100 mA to 1 A	(0.05 to 1) kHz	0.085 % + 0.03 µA 0.061 % + 0.2 µA 0.061 % + 2 µA 0.046 % + 20 µA 0.13 % + 0.2 mA	Agilent 3458A
(10 to 600) A (600 to 900) A	50/60 Hz	1.5 % + 1.5 A 2 % + 8 A	Clamp meter CM-6146

Parameter/Equipment	Range	CMC[2, 4, 5] (±)	Comments
Oscilloscope[3] –			
DC Voltage Amplitude	± 1 mV to 190 V	0.029 % + 29 µV	Wavetek 9500; the percentages are related to the reference level
Leveled Sine Wave	50 kHz to 10 MHz	1.8 %	Active head Wavetek 9510
Flatness	(0.050 to 100) MHz (Relative to 50 kHz to 10 MHz)	2.3 %	
	(100.01 to 550) MHz	3.8 %	
	(550.01 to 1000) MHz (Relative to 50 kHz to 10 MHz)	4.9 %	

Parameter/Equipment	Range	CMC[2, 4, 5] (±)	Comments
Oscilloscope[3] – (cont)			
Time Marker:			
Sine Wave	550 ps to 2 ns	0.001 %	
Square Wave	10 ns to 10 ms	0.001 %	

III. Electrical – RF/Microwave

Parameter/Range	Frequency	CMC[2, 4, 5] (±)	Comments
RF Power – Measure			
(-60 to 18) dBm	(10 to 50) MHz	4.2 %	Anritsu ML2437A MA2474D
	(50 to 100) MHz	4.1 %	
	(100 to 500) MHz	4.1 %	
	(500 to 1000) MHz	4.0 %	
	(1 to 2) GHz	4.1 %	
	(2 to 6) GHz	4.2 %	
	(6 to 12) GHz	4.2 %	
	(12 to 18) GHz	4.4 %	
	(18 to 26.5) GHz	4.9 %	
	(26.5 to 40) GHz	5.6 %	

IV. Optical Quantities

Parameter/Equipment	Range	CMC[2, 4, 6] (±)	Comments
Optical Time Domain Reflectometer – (OTDR): Distance	Up to 200 km	1.3 m/10 km range	FG-NS-OTDR-570 Fluke PM6681
Optical Spectrum Analyzer –			
Wavelength	(1480 to 1570) nm	2.0 pm	Burleigh WA-1150

Parameter/Equipment	Range	CMC[2, 4, 6] (±)	Comments
Optical Power – Absolute Power Measure, (1309, 1550) nm	(+2 to -50) dBm	4 % (0.17 dB)	ANDO AQ2735
Wavelength – Measure	(1270 to 1650) nm	2.0 pm	Burleigh WA-1150

V. Thermodynamics

Parameter/Equipment	Range	CMC[2, 6] (±)	Comments
Temperature – Measure[3]	(-60 to 100) °C (100 to 300) °C	0.25 °C 0.7 °C	Fluke Hydra 2625 w/ PT-100
Temperature – Uniformity Surveys[3]	(-60 to 300) °C	1.7 °C	Fluke Hydra 2625 w/ TC set
Relative Humidity – Measure[3]	(5 to 95) % RH	3 % RH	Rotronic Hygropalm HP-22w w/ HC2-S

VI. Time & Frequency

Parameter/Equipment	Range	CMC[2, 4, 6] (±)	Comments
Frequency – Measure			
Time Base	10 MHz (yearly)	5.4 parts in 10^{10}	SR FS 725 Rubidium frequency standard
Frequency	(0.001 to 100) Hz 100 Hz to 3 GHz	10 parts in 10^6 + 60 µHz 5.4 parts in 10^{10}	HP 53131A
	500 MHz to 40 GHz	5.4 parts in 10^{10}	HP 5351A, HP53152A

Parameter/Equipment	Range	CMC[2, 4, 6] (±)	Comments
Frequency – Measuring Equipment	(0.001 to 100) Hz 100 Hz to 15 MHz 10 MHz to 20 GHz (1 to 26.5) GHz	10 parts in 10^6 + 60 µHz 5.4 parts in 10^{10} 5.4 parts in 10^{10} 5.4 parts in 10^{10}	HP 33120A HP 83712B HP 8340B
Jitter – Measure & Measuring Equipment	(0.05 to 20) unit interval	2 % for null point of Bessel function, 4 % for other points	Agilent E4407B
Time & Time Interval – Measure[3]	Up to 1 minute	3 %	Oscilloscope

[1] This laboratory offers commercial calibration service and field calibration service.

[2] Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

[3] Field calibration service is available for this calibration. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the Calibration and Measurement Capability Uncertainty (CMC) found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

[4] In the statement of CMC, the value is defined as the percentage of reading, unless otherwise noted.

[5] The stated measured values are determined using the indicated instrument (see Comments). This capability is suitable for the calibration of the devices intended to measure or generate the measured value in the ranges indicated. CMCs are expressed as either a specific value that covers the full range or as a fraction/percentage of the reading plus a fixed floor specification.

[6] The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter.

[7] This scope meets A2LA's *P112 Flexible Scope Policy*.

Accredited Laboratory

A2LA has accredited

GEFEN ELECTRONIC SERVICES LTD.

Petah-Tikva, ISRAEL

for technical competence in the field of

Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (*refer to joint ISO-ILAC-IAF Communiqué dated April 2017*).

Presented this 8th day of October 2025.

Mr. Trace McInturff, Vice President, Accreditation Services
For the Accreditation Council
Certificate Number 3537.01
Valid to June 30, 2027

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.